

Exercising emittance measurements in the ATF EXT line



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The main goals of this study are :

- Explain why the measured vertical emittance is higher than the theoritical one.
- Quantify the **wire scanner error effect** on the emittance reconstruction method.
- Find a new emittance reconstruction method <u>less sensitive to wire scanner error</u>.
 (« Quadrupole Strengh Variation » method is under study).

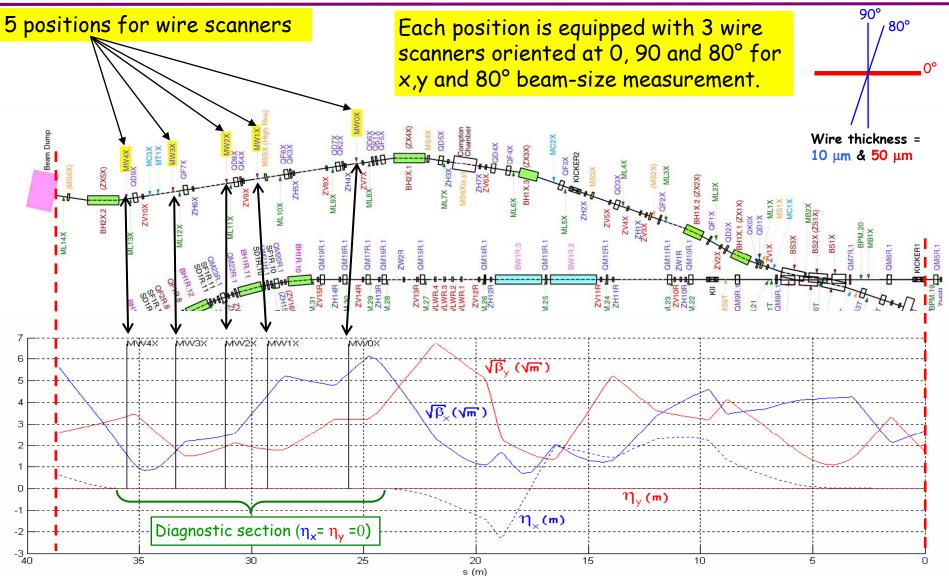
In this presentation, only a 4d method is presented... a 6d analysis migth be a possible upgrade of this study... Assumption :

- no jitter.
- no ground motion.
- perfect ATF-EXT line.
- no energy spread (E₀=1.3 GeV)



ATF EXT line description & wire scanner position

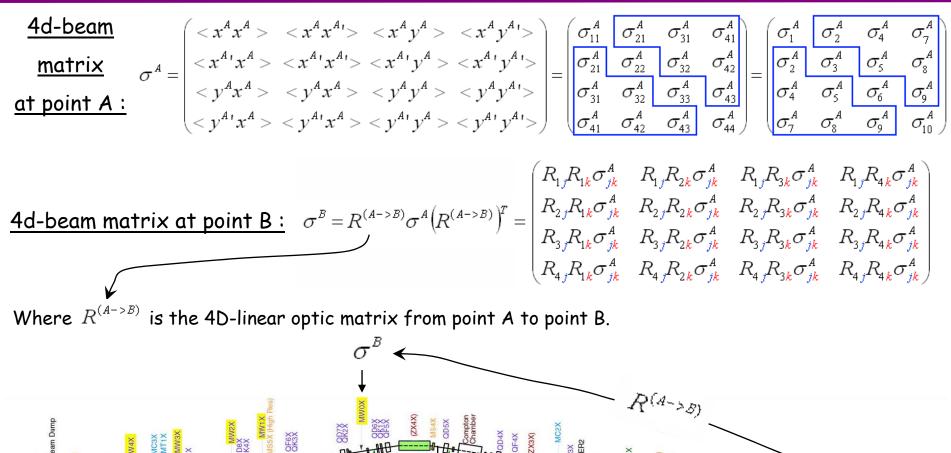






4d - reconstruction method based on 5 wire scanner measurements







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If the 4d-linear transport matrix from
$$R = \begin{pmatrix} R_{11} & R_{12} & 0 & 0 \\ R_{21} & R_{22} & 0 & 0 \\ 0 & 0 & R_{33} & R_{34} \\ 0 & 0 & R_{43} & R_{44} \end{pmatrix}$$

Then $\sigma_{11}^{B} = (R_{11}^{2}) \sigma_{1}^{A} + (2R_{11}R_{12}) \sigma_{2}^{A} + (R_{12}^{2}) \sigma_{3}^{A}$

 $\sigma_{33}^{B} = (R_{33}^{2})\sigma_{6}^{A} + (2R_{33}R_{34})\sigma_{9}^{A} + (R_{34}^{2})\sigma_{10}^{A}$

$$\sigma_{11}^{B} = (R_{11}^{2}) \sigma_{1}^{A} + (2R_{11}R_{12}) \sigma_{2}^{A} + (R_{12}^{2}) \sigma_{3}^{A} = (\sigma_{x}^{B})^{2} = (x-\text{beam size } \otimes B)^{2}$$

$$\sigma_{33}^{B} = (R_{33}^{2}) \sigma_{6}^{A} + (2R_{33}R_{34}) \sigma_{9}^{A} + (R_{34}^{2}) \sigma_{10}^{A} = (\sigma_{y}^{B})^{2} = (y-\text{beam size } \otimes B)^{2}$$

$$\sigma_{13}^{B} = (R_{11}R_{33}) \sigma_{4}^{A} + (R_{12}R_{33}) \sigma_{5}^{A} + (R_{11}R_{34}) \sigma_{7}^{A} + (R_{12}R_{34}) \sigma_{8}^{A}$$

-> For \ll n \gg points (B,C,...Z), where the x beam size is measure, we have :

$$\begin{pmatrix} \sigma_{11}^{B} \\ \sigma_{11}^{C} \\ \vdots \\ \sigma_{11}^{C} \\ \vdots \\ \sigma_{11}^{Z} \end{pmatrix} = \begin{pmatrix} R_{11}^{(A->B)2} & 2R_{11}^{(A->B)}R_{12}^{(A->B)} & R_{12}^{(A->B)2} \\ R_{11}^{(A->C)2} & 2R_{11}^{(A->C)}R_{12}^{(A->C)2} & R_{12}^{(A->C)2} \\ \vdots \\ \vdots \\ \sigma_{11}^{A} \end{pmatrix} = M_{X} \begin{pmatrix} \sigma_{1}^{A} \\ \sigma_{2}^{A} \\ \sigma_{3}^{A} \end{pmatrix} = M_{X} \begin{pmatrix} \sigma_{1}^{A} \\ \sigma_{2}^{A} \\ \sigma_{3}^{A} \end{pmatrix}$$

If we know how to solve this linear system then, we can compute the horizontal emittance :

$$\boldsymbol{\varepsilon}_{x}^{A} = \sqrt{\boldsymbol{\sigma}_{1}^{A} \cdot \boldsymbol{\sigma}_{3}^{A} - \left(\boldsymbol{\sigma}_{2}^{A}\right)^{2}}$$

0

0 0

 R_{33} R_{34}

Similar analysis can be performed to estimate : σ_4 , to σ_{10} ... and ε_y can be estimated.



4d - reconstruction method based on 5 wire scanner measurements



If n<3 No solution.

If n==3 and M_x^{-1} exist then the solution is known and unique.

If n>3 the sytem is « overestimated » and the Least Mean Square (LMS) method can be used to find the « LMS » solution. (in ATF n==5)

First question : How sensitive to wire scanner errors this method is ?

Second question : What happen if the QM6 quadrupole strength is reduce by 20%?



First question : How sensitive to wire scanner errors this method is ?



<u>Assumption</u>: the relative error level on « measurements » at position MWOX, MW1X, MW2X, MW3X and MW4X is identical, and tested for values ranging between 0 and 30%

WS	Sigma_x nominal (micron)	10% error (micron)	20% error (micron)	30% error (micron)	Wire scanner thickness (micron)
MW0X	238.67	24	48	72	10
MW1X	192.77	19	39	58	10
MW2X	109.4	11	22	33	10
МW3X	77.04	8	15	23	10
MW4X	70.14	7	14	21	10
	Sigma_y				
WS	nominal (microns)	10% error (micron)	20% error (micron)	30% error (micron)	Wire scanner thickness (micron)
WS MW0X	nominal				
	nominal (microns)		(micron)	(micron)	thickness (micron)
MW0X	nominal (microns) 14.46		(micron) 3	(micron) 4	thickness (micron)
MVVDX MVV1X	nominal (microns) 14.46 8.11		(micron) 3 2	(micron) 4 2	thickness (micron) 5 5

$$\sigma_{sim}^{X\%} = (1+r)\sigma_{ideal}$$

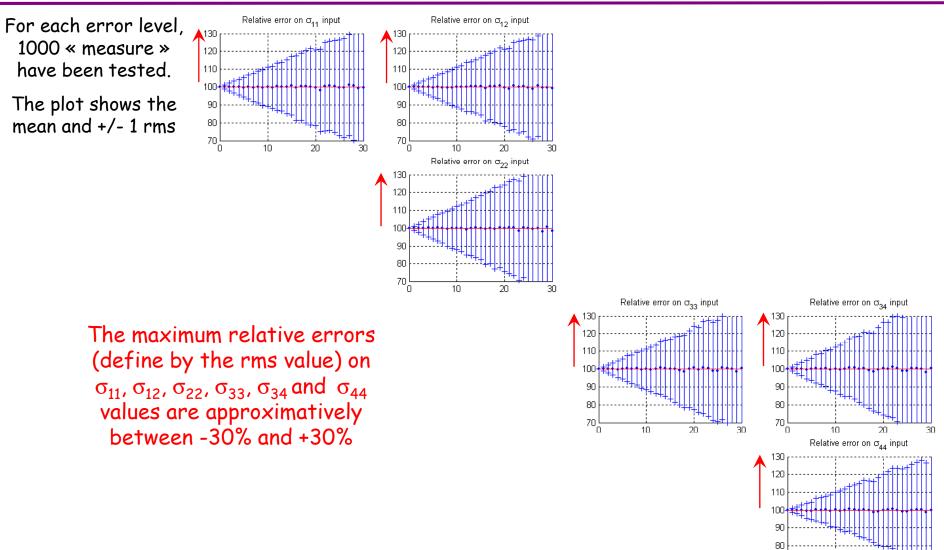
Where « r » comes from a gaussian distribution having zero mean and X/100 rms

The minimum relative error level for y-beam size measurement is at least equal to 13% (D/4~1.25 microns)



<u>First question</u>: How sensitive to wire scanner errors this method is ?





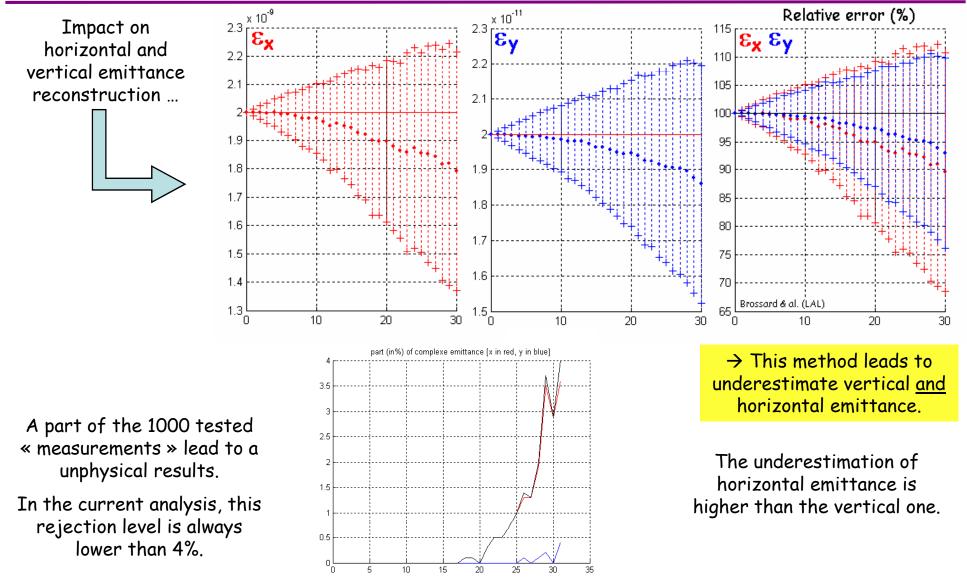
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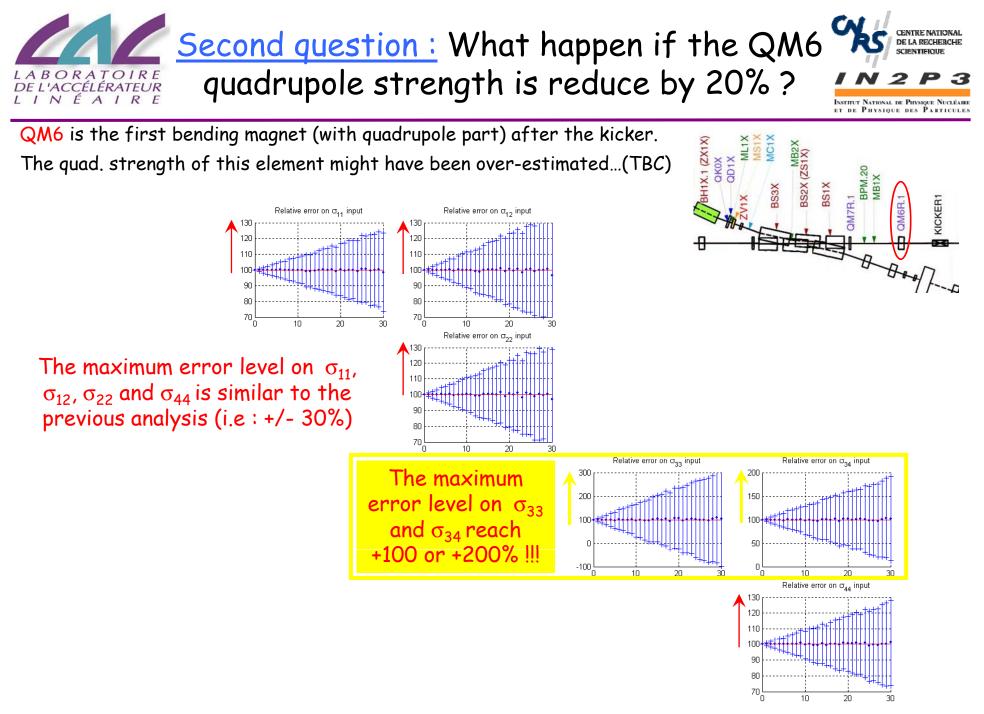
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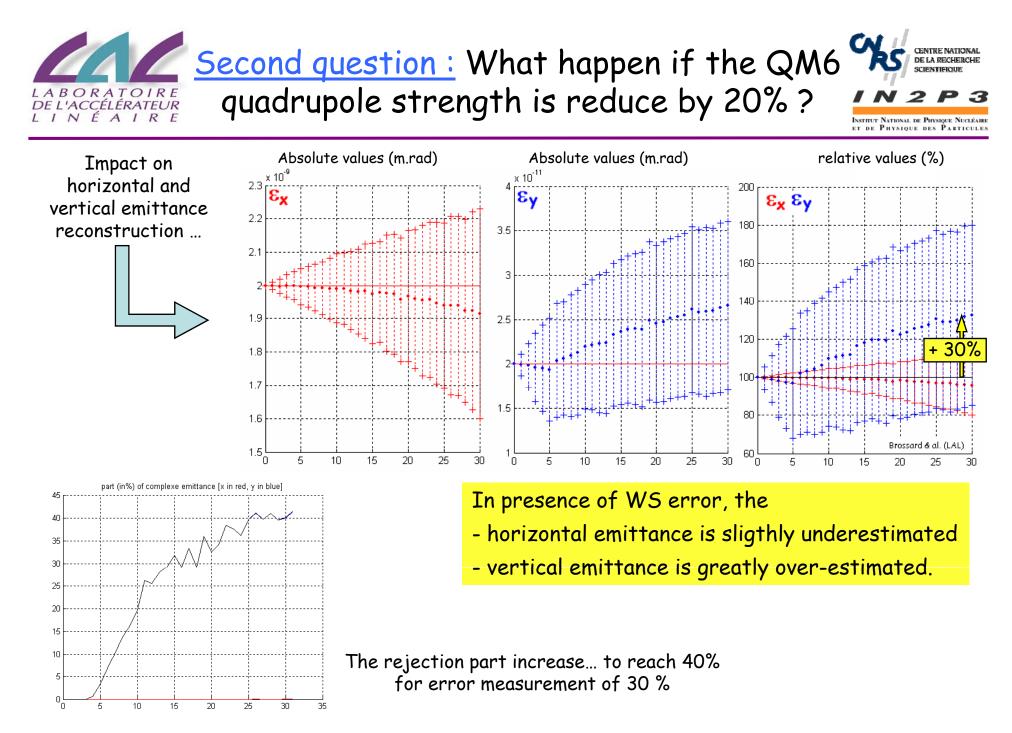


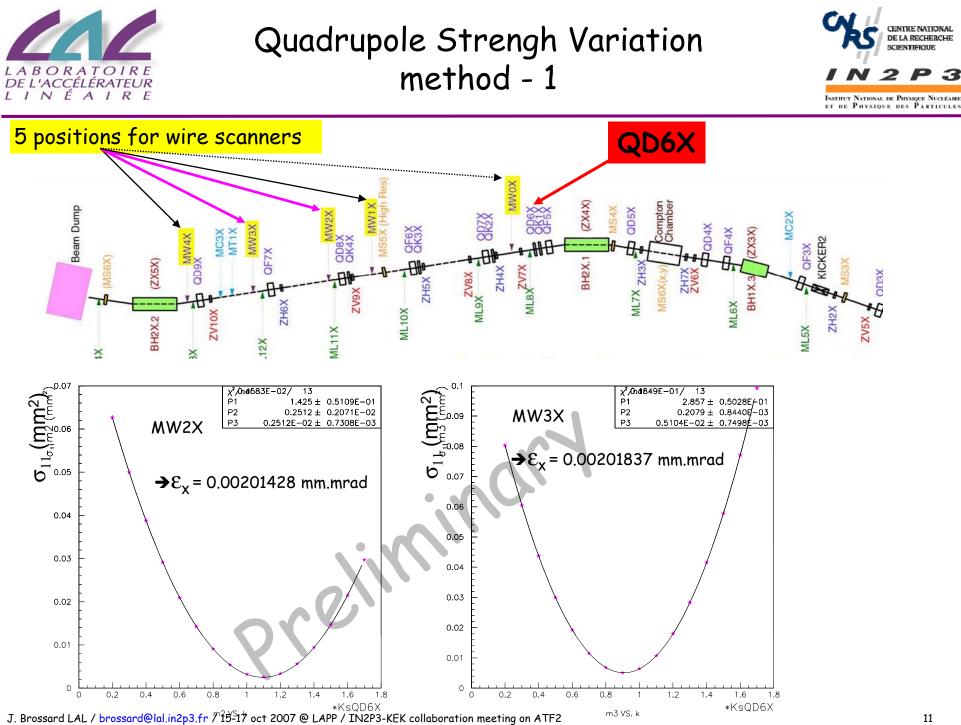
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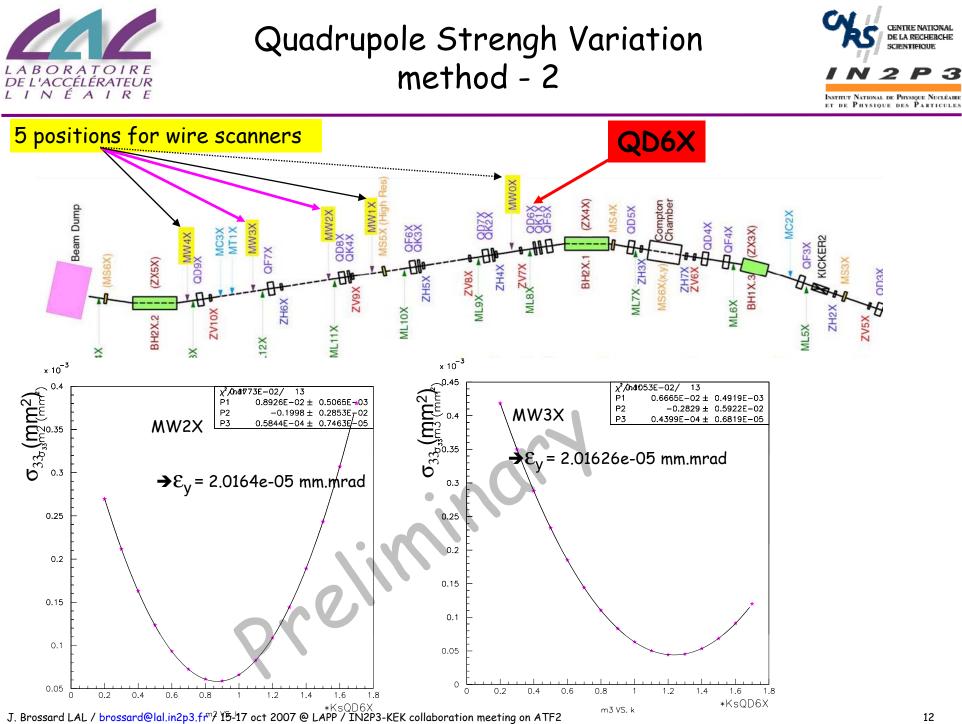














Conclusions and perspectives



Conclusions and persepctives

- For the nominal ATF-EXT line, the LMS* method based on the 5 <u>existing wire scanners</u> induced an <u>underestimation</u> of the vertical and horizontal emittance (function of WS error level).
- If the QM6 quadrupole strength is underestimated (by 20%) then the LMS method based on the 5 existing wire scanner induced a « small » horizontal emittance reduction and a « large » vertical emittance estimation (function of WS error level). <u>For QM7 quadrupole strength</u> <u>underestimation an symetric (x-y) effect is observed</u> (see extra slide).
- Compare the error sensitivity of the LMS reconstruction method with a « quadrupole strength variation » method.

<u>Questions</u>

- What are the real « quadrupole strength » of QM6 and QM7 (seen by the extracted bunch)?
- Is it possible to determine WS positions leading to less error sensitive reconstruction method?
- What is the sensitivity of « quadrupole strength variation » method ? (which quad ? which WS ?, new quad position ?, new WS position ?).
- Is it possible to realize more than 3 measurement per WS to reduce the error level?
- others ideas ? ...

^{*} LMS : Least Mean Square





Many thanks to Mark Woodley for the input MAD file (see : http://www.slac.stanford.edu/~mdw/ATF/EXT.mad)

<u>References :</u>

ATF Internal reports : ATF-99-01, ATF-00-06, ATF-99-17, ATF-99-08, ATF-00-01...

